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A 60 GHz First-Order Dual-Port Probe for Spherical Near-Field Antenna Measurements

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Abstract—We present the design, manufacturing, calibration, and testing of a first-order dual-port conical-horn probe for spherical near-field antenna measurements at 60 GHz. The measurement results demonstrate that the probe performance is acceptable, but they also illustrate the challenges for high-accuracy antenna measurements at millimeter-wave frequencies.

Index Terms—millimeter-waves, antennas measurements, near-field, dual-polarized probe

I. INTRODUCTION

For spherical near-field antenna measurements, first-order dual-port probes possess several advantages; in particular, they ensure an accurate, efficient, and stable near-field-to-far-field transformation using only one full-sphere scan of the antenna under test (AUT) [1], [2]. For these reasons, the DTU-ESA Spherical Near-Field Antenna Test Facility routinely employs first-order dual-port probes from 3-18 GHz. For the higher mm-wave frequencies, dual-port probes are challenged by reduced performances of orthomode transducers (OMT) and switches. Dual-port probes above 40 GHz based on OMTs with a turnstile junction for higher-order modes cancellation with two receiver channels have recently been reported [3], [4]. In this work, we present a first-order dual-port probe based on a high-directivity conical horn, designed and manufactured in-house, and commercially available cables, OMT, switch, and coax-to-waveguide adapters. We document its design, manufacturing, calibration (S-parameters, radiation pattern, power spectrum, polarization ratio, and channel balance) as well as its performance when employed as probe for measurement of a standard gain horn (SGH). Preliminary results were published in [5], [6]; this work gives a complete account with new and previously unpublished results and analysis.

II. DESIGN

The dual-port probe is shown in Fig. 1; it includes a conical horn, a square-to-circular transition (3.75 mm to 3.58 mm) from Sage Millimeter, a 50-75 GHz OMT from Sage Millimeter with a square antenna port of 3.75 mm, two coax-to-waveguide adapters from Flann Microwave, two 0-67 GHz cables with 1.85 mm connectors from Flann Microwave, and a 600 MHz-67 GHz single pole double throw (SPDT) switch from Ducommun. The switch and OMT are selected to have isolation better than 40 dB in the whole band in order to support a low cross-polarization of the probe. The conical horn is designed, using WIPL-D [7], to have 27 dB gain in order to partly compensate for the 83 dB path loss at 60 GHz for the 6 m measurement distance at the DTU-ESA Facility.

![Fig. 1: 60 GHz dual-port probe. For port 1, the switch connects J1 and J2, and for port 2, the switch connects J1 and J3. The square plate behind the conical horn is part of the standard mounting frame. Horn dimensions are shown in the insert.](image)

III. MEASUREMENT TESTS

A. S-parameters

Fig. 2 shows that the measured S-parameters of the two ports generally have the same frequency variation but also some specific differences; at 60 GHz, the $S_{11}$ and $S_{22}$ parameters are $-9$ dB and $-11$ dB, respectively. The $S_{21}$ and $S_{12}$ parameters show measured values well below $-40$ dB. It has been verified that the S-parameters are largely determined by the switch with little influence of the subsequent components.

B. Radiation pattern

The dual-port probe radiation pattern is measured without the switch in a spherical near-field facility using a single-port 25 dB SGH (Flann Microwave A6635 series) as probe. The two orthogonal components are measured individually for each probe port, resulting in four full-sphere scans. The measured radiation patterns are shown in Fig. 3 and in Fig. 4, together with WIPL-D simulation results [7]. The radiation patterns are based on the spherical wave expansion with truncation numbers $M = 25$ and $N = 90$ according to the minimum sphere of the dual-port probe.

From the radiation patterns in Fig. 3, and Fig. 4, it is noted that a very good agreement exists between measurements and simulations down to -20 dB pattern level for the co-polar
Fig. 2: Measured S-parameters for port 1 and port 2 of dual-port probe.

Fig. 3: Measured co-and cross-polar directivity radiation patterns for dual-port probe at 60 GHz for E-plane (top left), H-plane (top right), 45°-plane (bottom left), and 135°-plane (bottom right).

Fig. 4: Zoomed-in measured co-and cross-polar directivity radiation patterns for dual-port probe at 60 GHz for E-plane (top left), H-plane (top right), 45°-plane (bottom left), and 135°-plane (bottom right).

C. Probe Spherical Wave Expansion

To verify the first-order performance, the measured power spectrum of the spherical $m$- and $n$-modes is shown in Fig 5. It is seen that the power level of the higher-order $m$-modes is lower than -30 dB for port 1 and port 2 with a slightly increase in level for the odd-order $m$-modes. A likely cause of the higher-order modes presence in the $m$-modes spectrum at port 2, is a displacement or depointing of the dual-port probe with respect to the coordinate system origin, of the order of 1 mm or less. The ripples for the higher-order $n$-modes is due to the chosen coordinate system with the origin about 62 mm inside the aperture of the horn; for an origin close to the aperture, the $n$-mode spectrum would be more narrow and without such ripples (while the $m$-mode spectrum would be unchanged).

Since far most of the power is contained within the $m = 1$ mode, demonstrating that this is a good first-order probe. The simulated power spectrum (WIPL-D) is compared with the measured power spectrum. For measurements and simulations the sampling step in $\theta$ is 1° and in $\phi$ is 3°. The measurement results show a good agreement with the $m$-modes power level of the simulations and some differences between measurements and simulations in the $n$-modes. These are likely due to lack of absorbers in the simulations and to the different outer dual-port probe surfaces in measurements and in simulations, where only the inner dual-port probe structure is modelled.
D. Polarization and channel balance

The polarization and channel balance calibration is performed using the three antenna measurement procedure [1], wherein the first measurement employs two SGHs and the subsequent ones employ the dual-port probe and each of the two SGHs. This gives one polarization ratio for each probe port and two values for the channel balance; see Table I and Table II.

<table>
<thead>
<tr>
<th>Probe port</th>
<th>( p_1 )</th>
<th>( p_2 )</th>
</tr>
</thead>
<tbody>
<tr>
<td>Axial Ratio [dB]</td>
<td>40.9</td>
<td>53.2</td>
</tr>
<tr>
<td>Tilt Angle [°]</td>
<td>-0.1</td>
<td>89.3</td>
</tr>
</tbody>
</table>

A possible explanation for the difference in the channel balance values is the different cross-polarization properties of the two SGHs. In addition, the dual-port probe introduces losses reducing the dynamic range, and noise adds further uncertainty during calibration measurements. Channel balance \( A_{xy} \) is closer to the ideal value of 1 and this is selected for probe correction of the subsequent measurement results.

<table>
<thead>
<tr>
<th>Channel balance</th>
<th>Magnitude [dB]</th>
<th>Phase [°]</th>
</tr>
</thead>
<tbody>
<tr>
<td>( A_{xy1} )</td>
<td>0.02</td>
<td>127</td>
</tr>
<tr>
<td>( A_{xy2} )</td>
<td>-0.15</td>
<td>124</td>
</tr>
</tbody>
</table>

E. Gain

The near-field gain substitution technique is used; a SGH is used as gain reference antenna and this is calibrated with the two-antenna technique [8] to have a gain of 26.4 dB. The dual-port probe gain at 60 GHz gives at port 1 a value of 12.5 dB and a value of 11.8 dB at port 2. These gain values are significantly lower than the 27 dB gain of the horn itself; this is caused by the losses in the dual-port probe components. The difference between these gain values is due to different OMT port insertion loss values - a 0.4 dB difference (from OMT datasheet specifications) - and due to the insertion loss at port 2 of the cable, connecting the switch to the OMT, being around 1 dB larger than for the cable at port 1.

IV. Dual-Port Probe as a Probe

The dual-port probe is now tested as a probe for a spherical near-field measurement of a SGH (A6634 series from Flann Microwave) as an AUT. The AUT measured data with dual-port probe (DPP) is compared with the data from the measurements when a SGH A6635 (A35) is used as a probe. Fig. 6 and Fig. 7 show the AUT radiation pattern measured with A35 and DPP for the E-, H-, 45°- and 135°-planes. It can be noted that for measurements with A35 as probe, the dynamic range of the system (determined as the range from co-polar peak to cross-polar average level), is around 60 dB. When DPP is used as a probe, the dynamic range is around 50 dB, being reduced by approximately 10 dB. This effect is seen in the cross-polar component, showing a noise-like behavior when AUT is measured with DPP. However, the cross-polar on-axis level of the two data sets is the same, with a value of around -20 dB.

Fig. 6: Measured co-and cross-polar directivity radiation patterns for A6634 SGH at 60 GHz for E-plane (top left), H-plane (top right), 45°-plane (bottom left) and 135°-plane (bottom right).
The channel balance value determined as the average between E- and H-planes. For completeness, the data corrected with 135°-planes are more sensitive to the channel balance than E- and H-planes and for 45°- and 135°-planes (see Table III). The pattern standard uncertainty is calculated as being 1/3 of the maximum of the equivalent error signal between the two patterns [9]. The standard deviation results for the co-polar component show a very good agreement with the cross-polar component show a very good agreement with hundredths of dB for E-plane and for 45°- and 135°-planes and tenths of dB for H-plane. The cross-polar components show around 2.5 dB difference between the two measurements results.

<table>
<thead>
<tr>
<th>Planes</th>
<th>E</th>
<th>H</th>
<th>45°</th>
<th>135°</th>
</tr>
</thead>
<tbody>
<tr>
<td>Δ[dB]</td>
<td>0.05</td>
<td>2.2</td>
<td>0.1</td>
<td>2.5</td>
</tr>
</tbody>
</table>

When the AUT is tested with the dual-port probe, channel balance correction with different values - $A_{x,y_1}$ or $A_{x,y_2}$ - gives different cross-polarization components for 45°- and 135°-planes, but the same on-axis polarization level of -20 dB (see Fig. 8). If channel balance $A_{x,y_2}$ is used for the calibration, the overall level of the cross-polar component is higher than in the case when $A_{x,y_1}$ is applied. For the E- and H-planes no differences are noticed. This is due to the fact that 45°- and 135°-planes are more sensitive to the channel balance than E- and H-planes. For completeness, the data corrected with the channel balance value determined as the average between $A_{x,y_1}$ and $A_{x,y_2}$ is shown as well.

V. CONCLUSIONS

A 60 GHz dual-port probe based on switch technology has been designed, manufactured, calibrated, and tested at the DTU-ESA Spherical Near-Field Antenna Test Facility. The dual-port probe shows a good first-order performance, with the higher-order m-modes power level lower than -30 dB at port 1 and port 2. Channel balance calibration is important for mm-waves measurements, but the process at 60 GHz is more challenging and affected by the reduced dynamic range and sources of uncertainties such as mechanical alignment, which here become more significant. The measurement results when dual-port probe is tested as a probe and when a 25 dBi SGH is used as probe show a generally good agreement - within 0.05 dB (E-plane) and 0.1 dB (H-plane) for the co-polar component and within 2.5 dB for the cross-polar component. The dual-port probe introduces losses which reduces the dynamic range. This effect is more dominant in the cross-polar component where the larger differences between the two data sets are present. Overall, this work demonstrates that the dual-port probe can be used to conduct accurate measurements at 60 GHz, but it is limited by the switch technology.

REFERENCES


